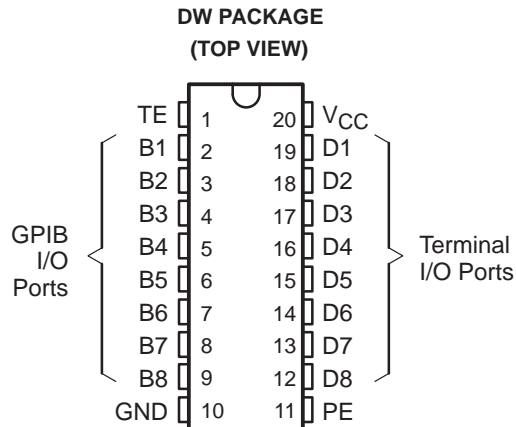


SN75ALS163

OCTAL GENERAL-PURPOSE INTERFACE BUS TRANSCEIVER

SLLS021E – JUNE 1986 – REVISED MAY 1998

- **8-Channel Bidirectional Transceiver**
- **High-Speed Advanced Low-Power Schottky Circuitry**
- **Low Power Dissipation . . . 46 mW Max per Channel**
- **Fast Propagation Times . . . 20 ns Max**
- **High-Impedance pnp Inputs**
- **Receiver Hysteresis . . . 650 mV Typ**
- **Open-Collector Driver Output Option**
- **No Loading of Bus When Device Is Powered Down ($V_{CC} = 0$)**
- **Power-Up/Power-Down Protection (Glitch Free)**



description

NOT RECOMMENDED FOR NEW DESIGNS

The SN75ALS163 octal general-purpose interface bus transceiver is a monolithic, high-speed, advanced low-power Schottky device. It is designed for two-way data communications over single-ended transmission lines. The transceiver features driver outputs that can be operated in either the open-collector or 3-state mode. If talk enable (TE) is high, these outputs have the characteristics of open-collector outputs when pullup enable (PE) is low and of 3-state outputs when PE is high. Taking TE low places the outputs in the high-impedance state. The driver outputs are designed to handle loads of up to 48 mA of sink current. Each receiver features pnp transistor inputs for high input impedance and 400 mV minimum of hysteresis for increased noise immunity.

Output glitches during power up and power down are eliminated by an internal circuit that disables both the bus and receiver outputs. The outputs do not load the bus when $V_{CC} = 0$.

The SN75ALS163 is characterized for operation from 0°C to 70°C.



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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SN75ALS163 OCTAL GENERAL-PURPOSE INTERFACE BUS TRANSCEIVER

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Function Tables

EACH DRIVER

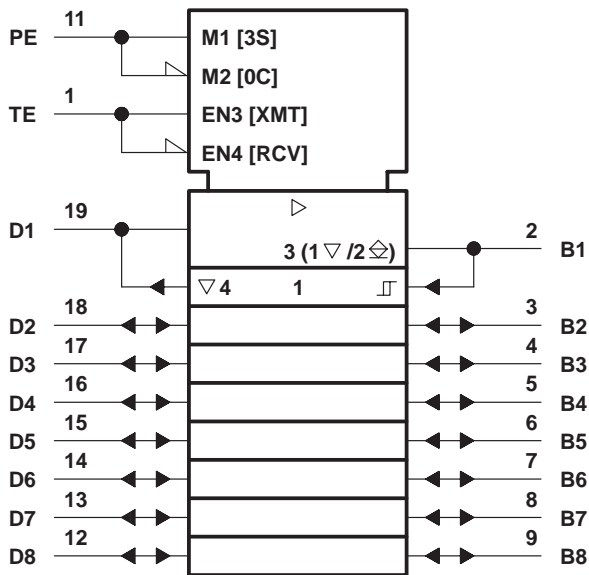
INPUTS			OUTPUT B
D	TE	PE	
H	H	H	H
L	H	X	L
H	X	L	Z
X	L	X	Z

EACH RECEIVER

INPUTS			OUTPUT D
B	TE	PE	
L	L	X	L
H	L	X	H
X	H	X	Z

H = high level, L = low level,
X = irrelevant, Z = high-impedance state

logic symbol†

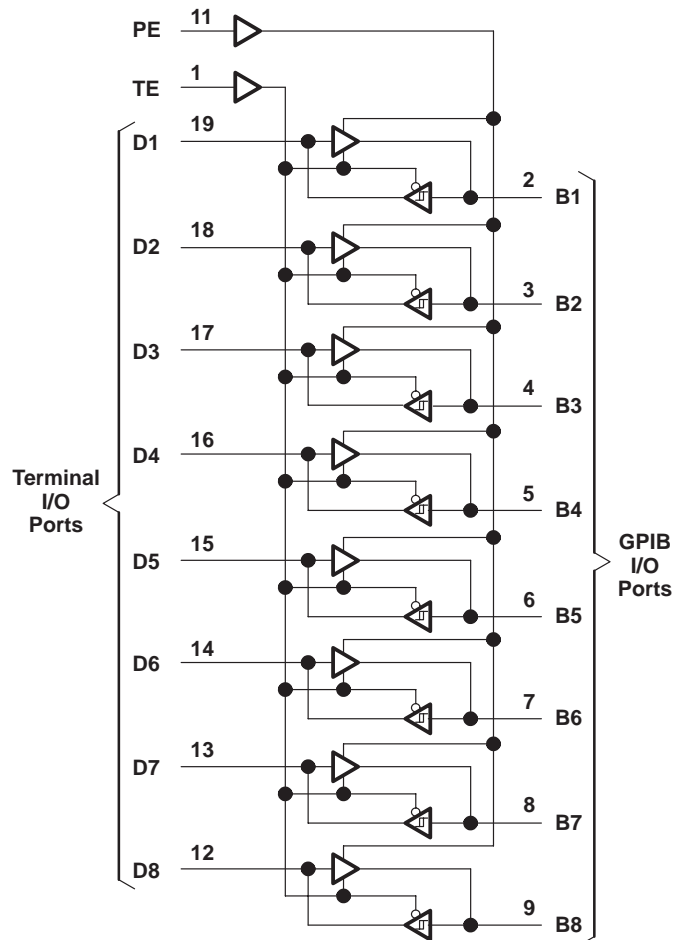


† This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

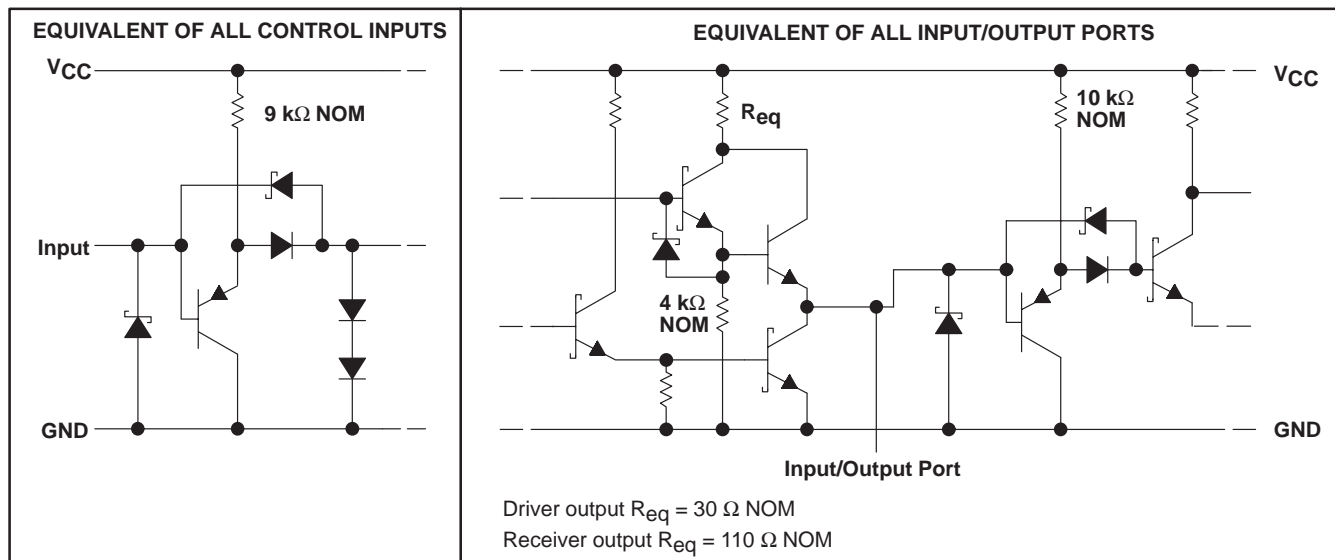
▽ Designates 3-state outputs

◇ Designates open-collector outputs

logic diagram (positive logic)



schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V _{CC} (see Note 1)	7 V
Input voltage, V _I	5.5 V
Low-level driver output current	100 mA
Package thermal impedance, θ _{JA} (see Note 2)	97°C/W
Storage temperature range, T _{stg}	– 65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from the case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES: 1. All voltage values are with respect to network ground terminal.
2. The package thermal impedance is calculated in accordance with JESD 51.

recommended operating conditions

		MIN	NOM	MAX	UNIT
Supply voltage, V _{CC}		4.75	5	5.25	V
High-level input voltage, V _{IH}		2			V
Low-level input voltage, V _{IL}				0.8	V
High-level output current, I _{OH}	Bus ports with pullups active			– 5.2	mA
	Terminal ports			– 800	μA
Low-level output current, I _{OL}	Bus ports			48	mA
	Terminal ports			16	mA
Operating free-air temperature, T _A		0		70	°C

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OCTAL GENERAL-PURPOSE INTERFACE BUS TRANSCEIVER

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electrical characteristics over recommended supply-voltage and operating free-air temperature ranges (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MIN	TYP†	MAX	UNIT	
V _{IK}	Input clamp voltage	I _I = -18 mA		-0.8	-1.5		V	
V _{hys}	Hysteresis (V _{T+} - V _{T-})	Bus		0.4	0.65		V	
V _{OH}	High-level output voltage	Terminal	I _{OH} = -800 μA, TE at 0.8 V	2.7	3.5		V	
		Bus	I _{OH} = -5.2 mA, PE and TE at 2 V	2.5	3.3			
V _{OL}	Low-level output voltage	Terminal	I _{OL} = 16 mA, TE at 0.8 V	0.3	0.5		V	
		Bus	I _{OL} = 48 mA, TE at 2 V	0.35	0.5			
I _{OH}	High-level output current (open-collector mode)	Bus	V _O = 5.5 V, PE at 0.8 V, D and TE at 2 V			100	μA	
I _{OZ}	Off-state output current (3-state mode)	Bus	PE at 2 V, V _O = 2.7 V			20	μA	
			TE at 0.8 V, V _O = 0.5 V			-100		
I _I	Input current at maximum input voltage	Terminal	V _I = 5.5 V		0.2	100	μA	
I _{IH}	High-level input current	Terminal, PE, or TE	V _I = 2.7 V		0.1	20	μA	
I _{IL}	Low-level input current		V _I = 0.5 V		-10	-100		
I _{OS}	Short-circuit output current	Terminal		-15	-35	-75	mA	
		Bus		-25	-50	-125		
I _{CC}	Supply current		No load	Terminal outputs low and enabled		42	65	mA
				Bus outputs low and enabled		52	80	
C _{I/O(bus)}	Bus-port capacitance	V _{CC} = 0 to 5 V, V _{I/O} = 0 to 2 V, f = 1 MHz			30		pF	

† All typical values are at V_{CC} = 5 V, T_A = 25°C.

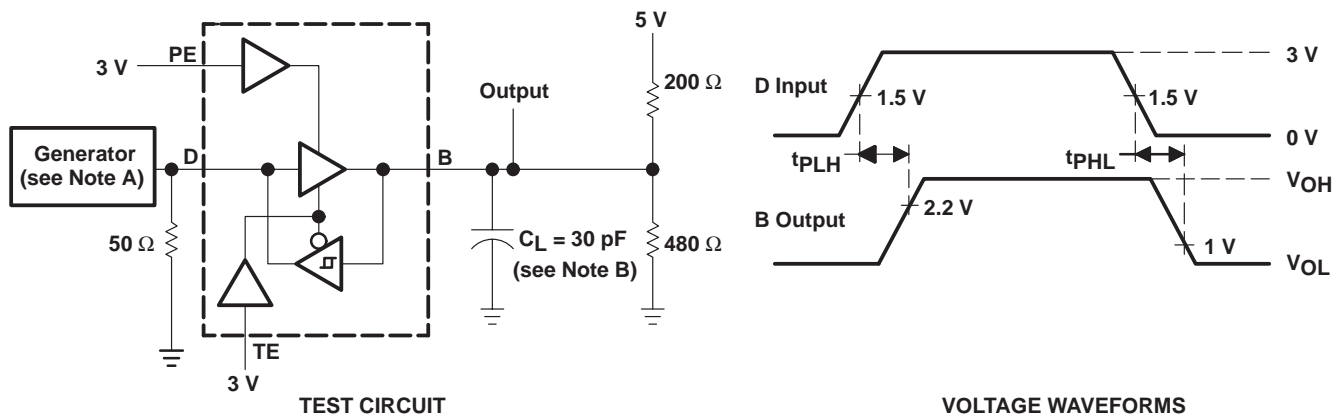
switching characteristics over recommended operating free-air temperature range (unless otherwise noted), V_{CC} = 5 V

PARAMETER		FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	MIN	TYP†	MAX	UNIT
t _{PLH}	Propagation delay time, low-to-high-level output	Terminal	Bus	C _L = 30 pF, See Figure 1		7	20	ns
t _{PHL}	Propagation delay time, high-to-low-level output					8	20	
t _{PLH}	Propagation delay time, low-to-high-level output	Bus	Terminal	C _L = 30 pF, See Figure 2		7	14	ns
t _{PHL}	Propagation delay time, high-to-low-level output					9	14	
t _{PZH}	Output enable time to high level	TE	Bus	C _L = 15 pF, See Figure 3		19	30	ns
t _{PHZ}	Output disable time from high level					5	12	
t _{PZL}	Output enable time to low level					16	35	
t _{PLZ}	Output disable time from low level					9	20	
t _{PZH}	Output enable time to high level	TE	Terminal	C _L = 15 pF, See Figure 4		13	30	ns
t _{PHZ}	Output disable time from high level					12	20	
t _{PZL}	Output enable time to low level					12	20	
t _{PLZ}	Output disable time from low level					11	20	
t _{en}	Output pull-up enable time	PE	Bus	C _L = 15 pF, See Figure 5		11	22	ns
t _{dis}	Output pull-up disable time					6	12	

† All typical values are at V_{CC} = 5 V, T_A = 25°C.

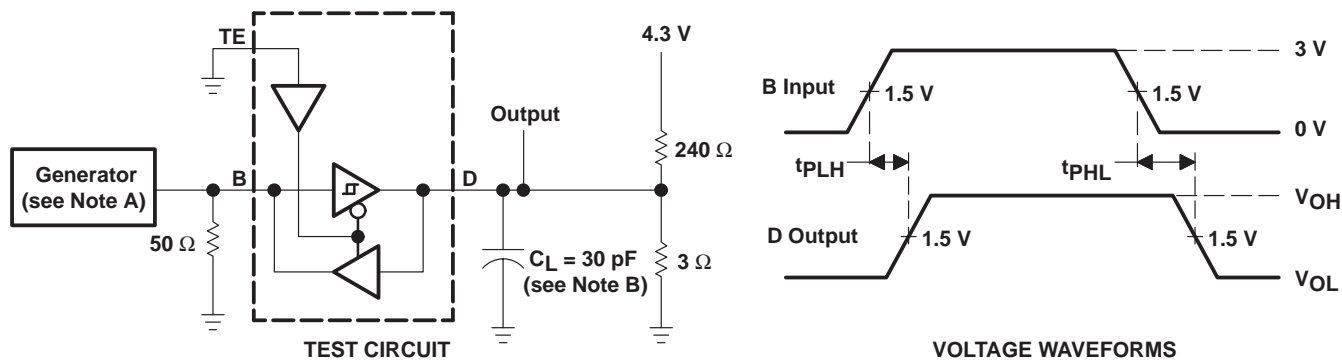


PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.
 B. C_L includes probe and jig capacitance.

Figure 1. Terminal-to-Bus Test Circuit and Voltage Waveforms



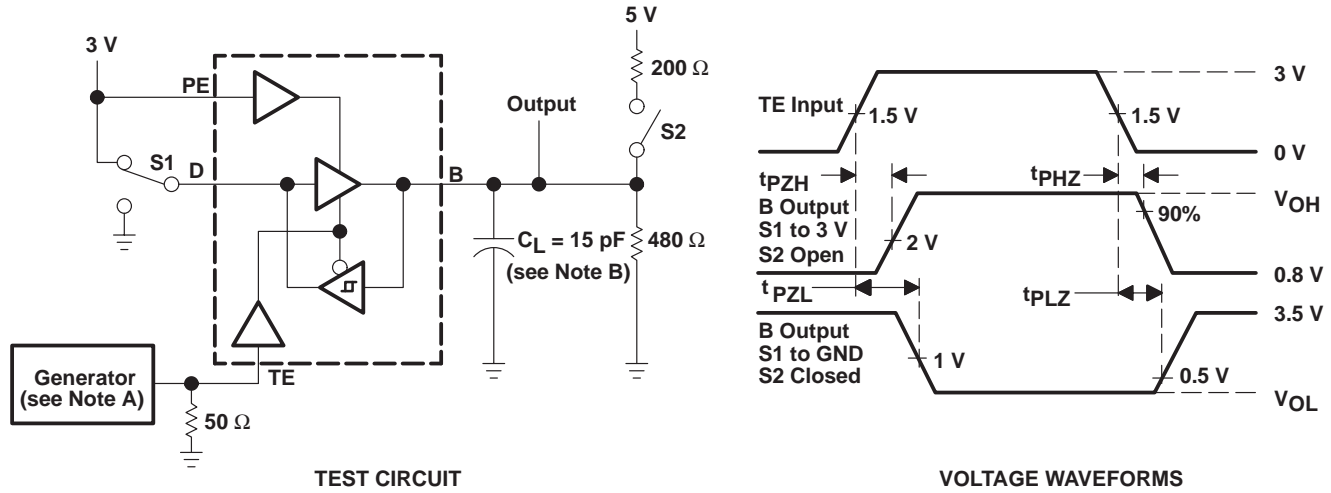
- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.
 B. C_L includes probe and jig capacitance.

Figure 2. Bus-to-Terminal Test Circuit and Voltage Waveforms

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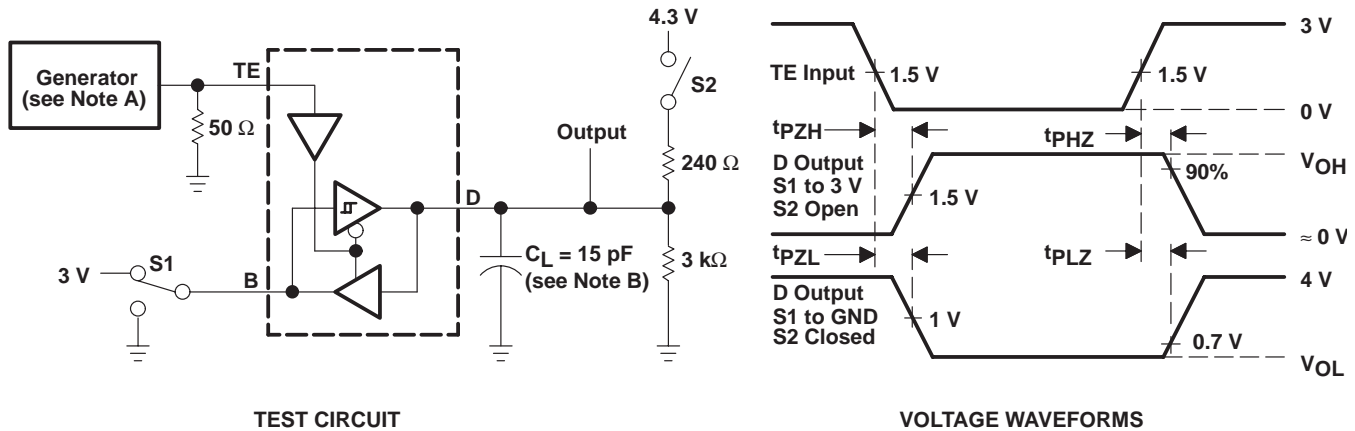
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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.
 B. C_L includes probe and jig capacitance.

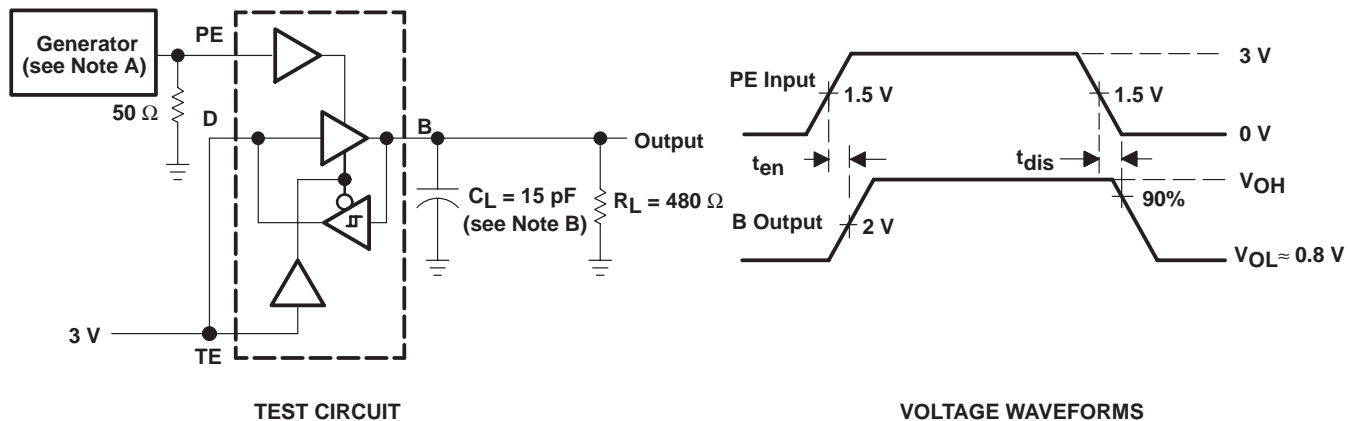
Figure 3. TE-to-Bus Test Circuit and Voltage Waveforms



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_O = 50 \Omega$.
 B. C_L includes probe and jig capacitance.

Figure 4. TE-to-Terminal Test Circuit and Voltage Waveforms

PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, 50% duty cycle, $t_r \leq$ 6 ns, $t_f \leq$ 6 ns, $Z_0 = 50 \Omega$.
 B. C_L includes probe and jig capacitance.

Figure 5. PE-to-Bus Test Circuit and Voltage Waveforms

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TYPICAL CHARACTERISTICS

TERMINAL HIGH-LEVEL OUTPUT VOLTAGE
vs
HIGH-LEVEL OUTPUT CURRENT

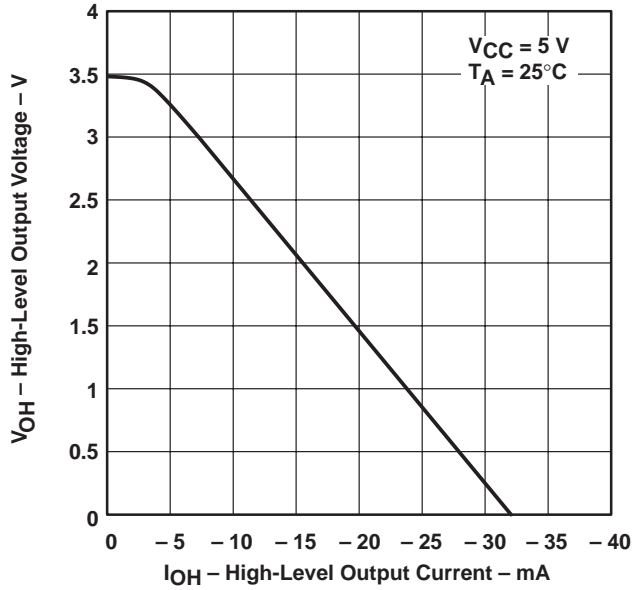


Figure 6

TERMINAL LOW-LEVEL OUTPUT VOLTAGE
vs
LOW-LEVEL OUTPUT CURRENT

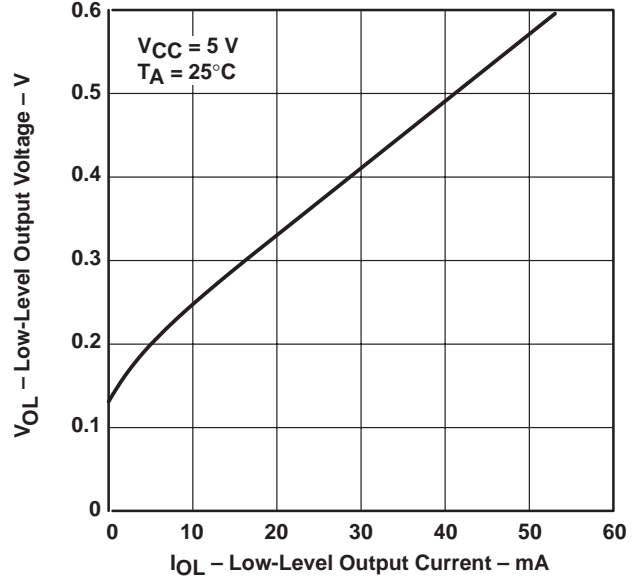


Figure 7

TERMINAL OUTPUT VOLTAGE
vs
BUS INPUT VOLTAGE

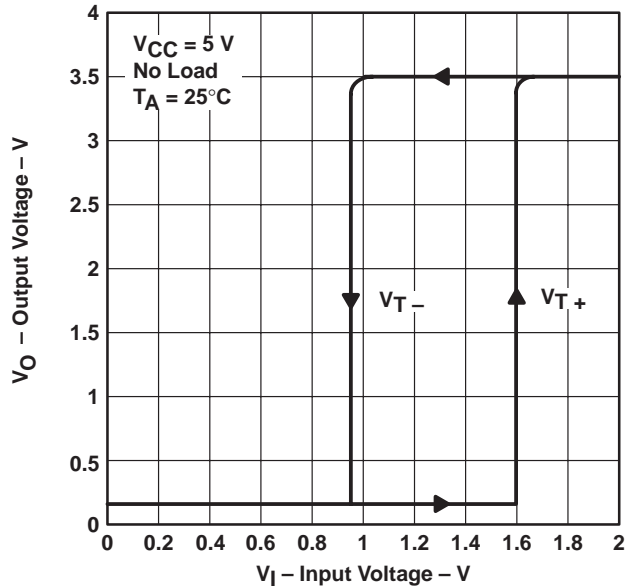


Figure 8

TYPICAL CHARACTERISTICS

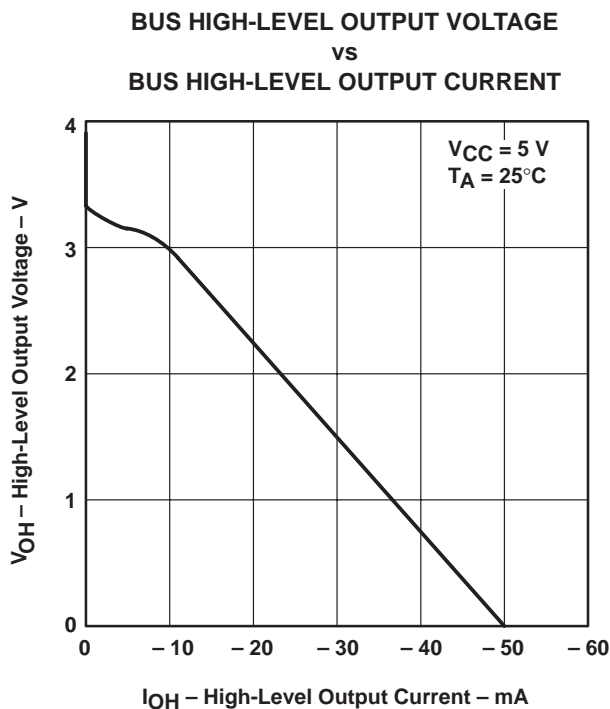


Figure 9

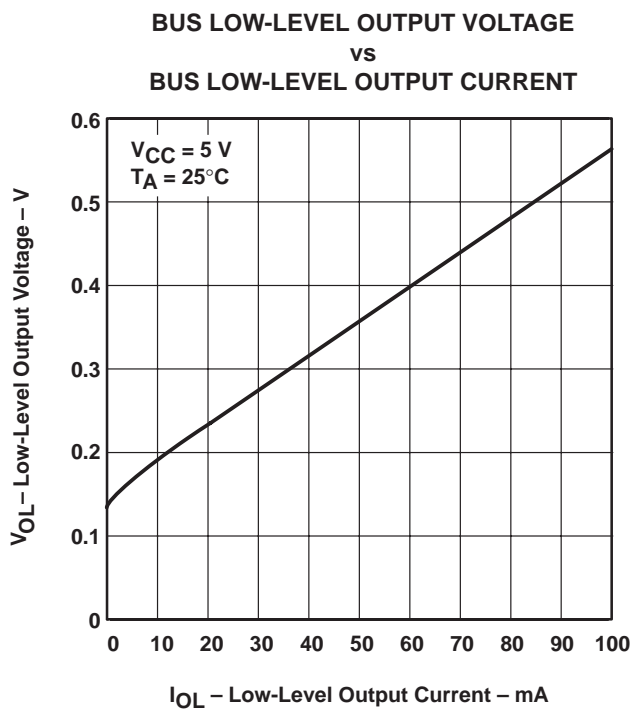


Figure 10

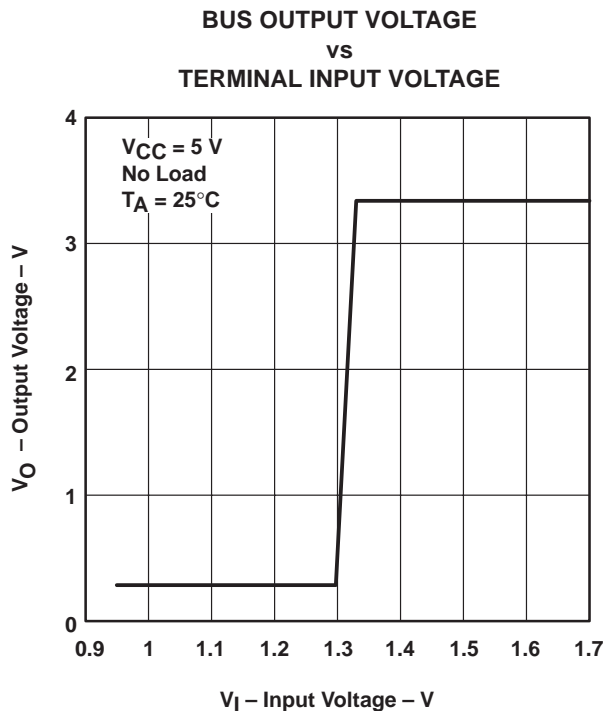


Figure 11

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